

25-Nov-2011 Rev B

0.6mm Pitch Champ Docking Connector

1. SCOPE

1.1. CONTENTS

This specification covers the requirements for product performance, test methods and quality assurance provisions of 0.6 mm pitch champ docking connector.

1.2. QUALIFICATION

When tests are performed on the subject product line, the procedures specified in EIA-364 series specifications shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENT

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence.

2.1. TE CONNECTIVITY SPECIFICATIONS

- A. 109-5000: Test Specification. General Requirements for Test Methods
- B. 109-197: TE Connectivity Test Specification cross reference EIA and IEC Test Methods.
- C. 501-99033: Test Report

2.2. COMMERCIAL STANDARDS AND SPECIFICATIONS

A. EIA-364: Electrical Connector/Socket Test Procedures Including Environmental Classifications.

3. REQUIREMENTS

3.1. DESIGN AND CONSTRUCTION

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. MATERIALS

RECEPTACLE:

- A. Housing: High temp. thermoplastic, UL94V-0.
- B. Contact: Copper alloy, gold plating on contact area, tin plating on soldertail over nickel underplating overall.
- C. Shell: Stainless steel, nickel plating overall.
- D. Bracket: Stainless steel (2129260-1).
- E. Bush: Steel, nickel plating overall (2129260-1).

PLUG:

- A. Housing: High temp. thermoplastic, UL94V-0.
- B. Contact: Copper alloy, gold plating on contact area, tin plating on soldertail over nickel underplating overall.
- C. Shell: Stainless steel, nickel plating overall.
- D. Cap: High temp. thermoplastic, UL94V-0.

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3.3. RATINGS

A. Voltage: 30V AC

B. Current: For Signal: 0.5 A Max.

For Power: 1A Max per pair, total capacity 2A/2 pairs.

C. Temperature: - 40°C to 85°C.

3.4. PERFOMANCE REQUEIREMENT AND TEST DESCRIPTION

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Fig.1. All tests shall be performed in the room temperature, unless otherwise specified.

3.5. TEST REQUIREMENTS AND PROCEDURES SUMMARY

Test Item		Requirement	Procedure			
	Examination of	Meets requirements of product	Visual inspection.			
1	Product	drawing. No physical damage.	EIA-364-18			
Electrical Requirement						
2	Low Level Contact Resistance	50 mΩ MAX	Subject mated contacts assembled in housing to 20mV Max open circuit at 10mA Max. EIA-364-23. (measuring			
3	Dielectric withstanding Voltage	No creeping discharge or flashover shall occur. Current leakage: 0.5 mA MAX	point shown in Fig 3) 0.25 kVAC, 1 minute. Test between adjacent circuits of mated connectors. EIA-364-20B Method B			
4	Insulation Resistance	500 MΩ minimum (Initial) 100 MΩ minimum (Final)	Impressed voltage 500 VDC. Test between adjacent circuits of unmated connector. EIA-364-21C			
5	Temperature Rising	30 °C Max. whole contacts under loaded specified current (0.5A.)	Measure temperature rising by energized current. (measuring point shown in Fig 3) EIA-364-70A			
	Mechanical Requirement					
6	Connector Mating Initial ,after interval Measure the Force 14N (1.428 Kgf) Max		Operation Speed: 12.5±3 mm/min. Measure the force required to mate connector. EIA-364-13B			
7	Connector Un-mating Force	Initial ,after interval 1N(0.102 kgf) Min 4N(0.408 kgf) Min for cable	Operation Speed: 12.5±3 mm/min. Measure the force required to unmate connector. EIA-364-13B			

Figure 1 (continued)

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Test Item		Requirement	Procedure			
	Mechanical Requirement					
	Durability		Operation Speed: 12.5mm/min.			
8		Δ R=25 m Ω Max. (Final).	Durability Cycles: 10000 Cycles,			
			EIA-364-9C			
			Subject mated connectors to 10-55-10			
		No electrical discontinuity	Hz traversed in 1minutes at 1.52mm			
9	Vibration	greater than 1 μ sec shall occur.	amplitude 2 hours each of 3 mutually			
		See Note.	perpendicular planes.			
			100mA Max. Applied. EIA-364-28D			
			Accelerate velocity: 490m/s² (50G)			
			Waveform:Half-sine shock plus			
		No electrical discontinuity	Duration: 11msec			
10	Mechanical Shock	greater than 1 μ sec shall occur.	No. of drops : 3 drops each to normal and			
		See Note.	reversed directions of X,Y and Z axes,			
			totally 18 drops, passing DC 1mA			
			current during the test. EIA-364-27B			
		Environmental Requir	rements			
	Solder ability		Solder Temperature ∶ 245+/-5℃			
			Duration:3+/-0.5sec,			
11		Wet solder coverage: 95% Min.	Flux : Alpha 100 (NON-active rosi			
			base)			
			EIA-364-638.			
			Pre-soak condition, 85 °C /85% RH for			
			168 hours.			
			Pre Heat : 150~200°C, 60~180sec.			
12		No physical damage shall	Time over liquids (217°C),60~150sec.			
		occur.	Peak Temp.: 260+0/-5°C, 20~40sec.			
			TEC-109-201, Condition B			
			Shown in Fig. 4			
			9			

Figure 1 (continued)

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TEST ITEM		REQUIREMENT	PROCEDURE	
Environmental Requirements				
13	Thermal Shock	Δ R=25 m Ω Max. (Final).	Mated Connector -55+/-3°C (30 minutes), +85+/-2°C (30minutes) Perform this a cycle, repeat 10 cycles EIA-364-32C,condition A	
14	Humidity Temperature Cycle	Δ R=25 m Ω Max. (Final).	Mated Connector 40°C , 90~95% RH, 10 Cycles, 24hr a cycle EIA-364-31B, Method II, Test condition A.	
15	Temperature Life (Heat Aging)	ΔR=25 mΩ Max. (Final).	Mated Connector 85±5°C , 96 hours, EIA-364-17B.	
16	and 5+/-1% salt condition for 4 Δ R=25 m Ω Max. (Final). After test, rinse the sample with and recondition the room temp		Subject mated connectors to 35+/-2 °C and 5+/-1% salt condition for 48hours. After test, rinse the sample with water and recondition the room temperature for 1 hour. EIA-364-26B.cond. B	

Figure 1 (End)

NOTE: Shall meet visual requirements, show no physical damage, and meet requirement of additional tests as specified in the test sequence in Figure 2.

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3.6. PRODUCT QUALIFICATION AND REQUALIFICATION TEST

	Test Group							
Test or Examination	Α	В	С	D(b)	Е	F	G	Н
	Test Sequence (a)							
Examination of Product	1,7	1,6	1	1,6	1	1,3	1,3	1,3
Low Level Contact Resistance	2,6	2,5	2,4	2,5	4,8			
Dielectric withstanding Voltage					3,7			
Insulation Resistance					2,6			
Temperature Rising						2		
Mating Force	3							
Unmating Force	4							
Durability	5							
Vibration				3				
Mechanical Shock				4				
Solderability							2	
Resistance to Soldering Heat								2
Thermal Shock		4						
Humidity Temperature Cycling					5			
Temperature Life		3						
Salt Spray			3					

Figure 2

NOTE: (a) Numbers indicate sequence in which tests are performed.

(b) Discontinuities shall not take place in this test group during test.

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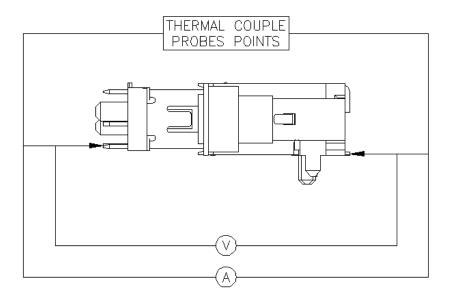
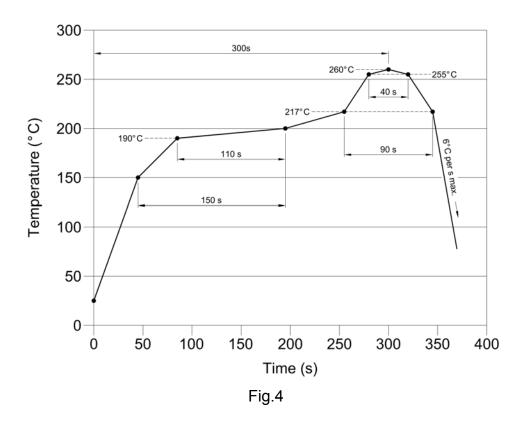


Fig.3 Contact Resistance and Temperature Rising Measuring Points



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APPLICABLE PART NUMBER AND DESCRIPTION

Part Number	Description		
□-2129260-□	RECEPTACLE ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS		
□-2129261-□	PLUG ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS		
□-2129273-□	REC. ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS, OFFSET		
□-2129276-□	CABLE PLUG ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS		
□-2129326-□	RECEPTACLE ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40POS		
□-2129327-□	PLUG ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40POS		
□-2129364-□	RECEPTACLE ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS		
□-2129367-□	PLUG ASSY, 0.6mm PITCH CHAMP DOCKING CONNECTOR, 40 POS		

Appendix 1

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